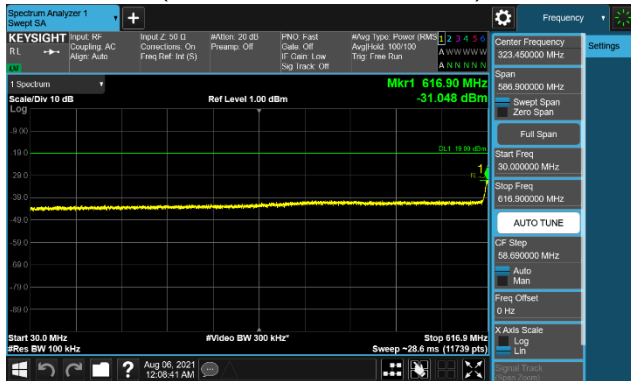




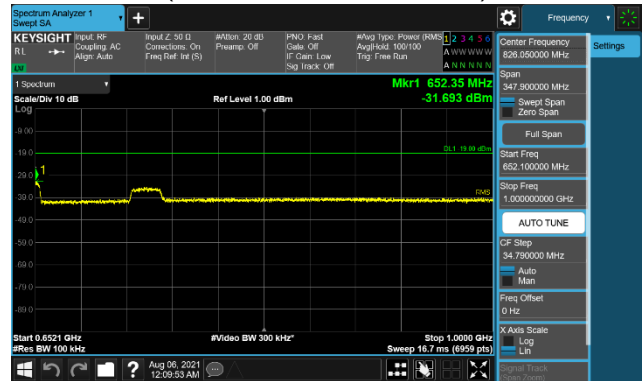
Plot 7-137. Conducted Spurious Emission Plot (9kHz to 150kHz)
(B71 LTE 1C 20M – Mid Channel)



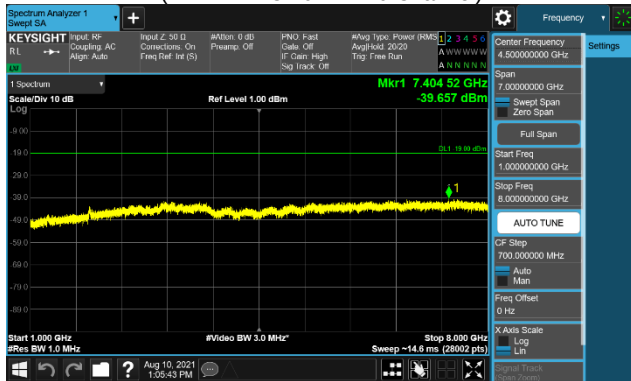
Plot 7-138. Conducted Spurious Emission Plot (150kHz to 30MHz)
(B71 LTE 1C 20M – Mid Channel)



Plot 7-139. Conducted Spurious Emission Plot (30MHz to 616.9MHz)
(B71 LTE 1C 20M – Mid Channel)

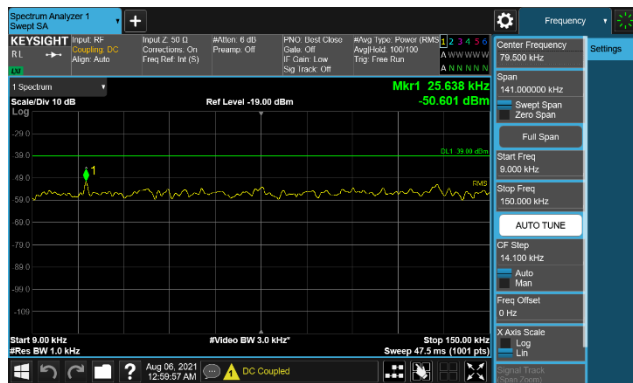


Plot 7-140. Conducted Spurious Emission Plot (652.1MHz to 1GHz)
(B71 LTE 1C 20M – Mid Channel)

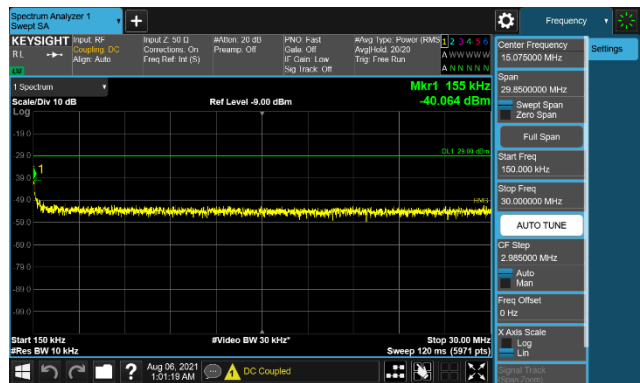


Plot 7-141. Conducted Spurious Emission Plot (1GHz to 8GHz)
(B71 LTE 1C 20M – Mid Channel)

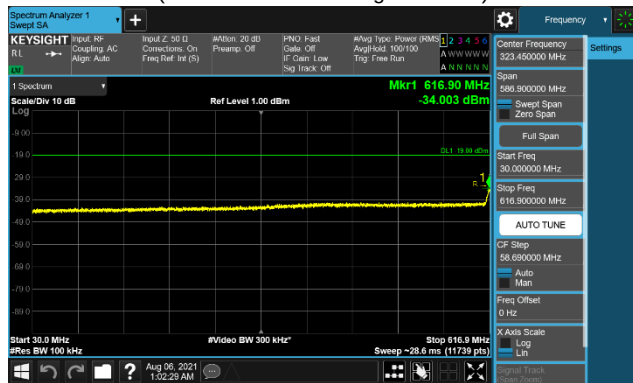
FCC ID: A3LRF4435D-71A	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 102 of 166



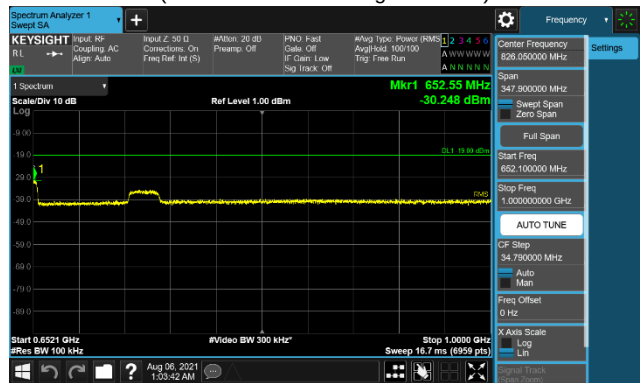
Plot 7-142. Conducted Spurious Emission Plot (9kHz to 150kHz)
(B71 LTE 1C 20M – High Channel)



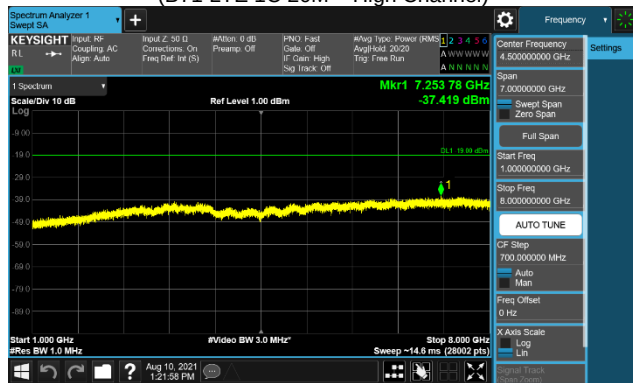
Plot 7-143. Conducted Spurious Emission Plot (150kHz to 30MHz)
(B71 LTE 1C 20M – High Channel)



Plot 7-144. Conducted Spurious Emission Plot (30MHz to 616.9MHz)
(B71 LTE 1C 20M – High Channel)



Plot 7-145. Conducted Spurious Emission Plot (652.1MHz to 1GHz)
(B71 LTE 1C 20M – High Channel)



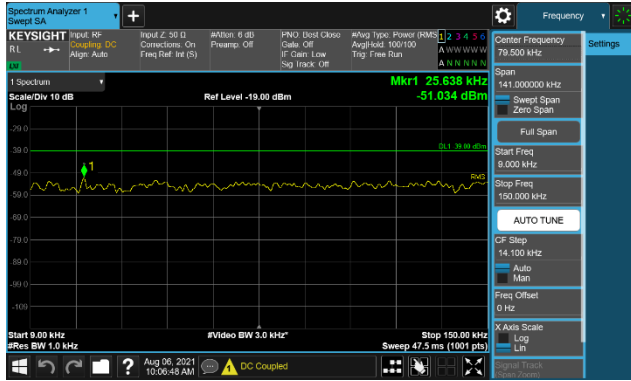
Plot 7-146. Conducted Spurious Emission Plot (1GHz to 8GHz)
(B71 LTE 1C 20M – High Channel)

FCC ID: A3LRF4435D-71A	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 103 of 166

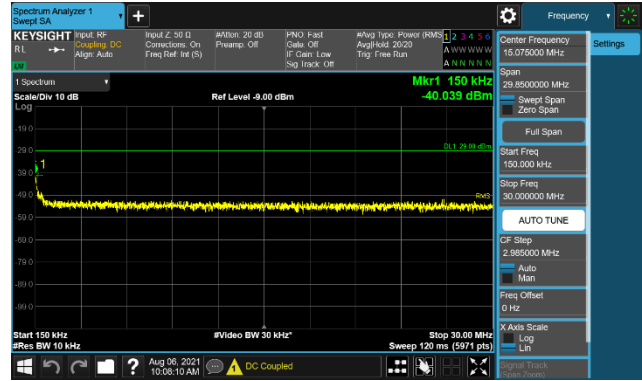
Ch.	Port #	Measurement Range	Level (dBm)	Limit (dBm)
			QPSK	
Low	0	9 kHz to 150 kHz	-51.03	-39.0
		150 kHz to 30 MHz	-40.04	-29.0
		30 MHz to 616.9 MHz	-22.80	-19.0
		652.1 MHz to 1 GHz	-29.20	-19.0
		1 GHz to 8 GHz	-37.30	-19.0
Middle	0	9 kHz to 150 kHz	-50.41	-39.0
		150 kHz to 30 MHz	-38.89	-29.0
		30 MHz to 616.9 MHz	-26.48	-19.0
		652.1 MHz to 1 GHz	-24.88	-19.0
		1 GHz to 8 GHz	-37.50	-19.0
High	3	9 kHz to 150 kHz	-50.55	-39.0
		150 kHz to 30 MHz	-40.50	-29.0
		30 MHz to 616.9 MHz	-32.64	-19.0
		652.1 MHz to 1 GHz	-26.63	-19.0
		1 GHz to 8 GHz	-37.52	-19.0

Table 7-44. Conducted Spurious Emission Summary Data (B71 LTE 2C 10M+10M Conti)

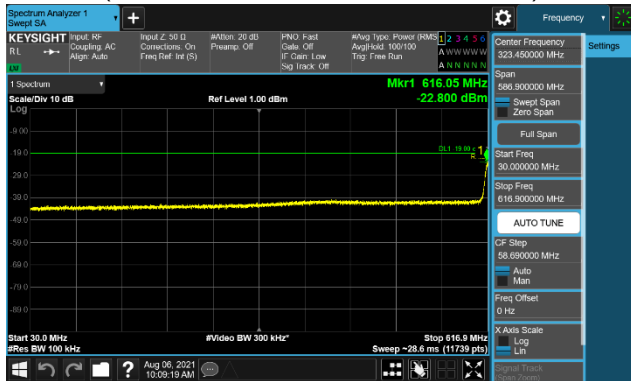
FCC ID: A3LRF4435D-71A		MEASUREMENT REPORT (CERTIFICATION)		Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 104 of 166



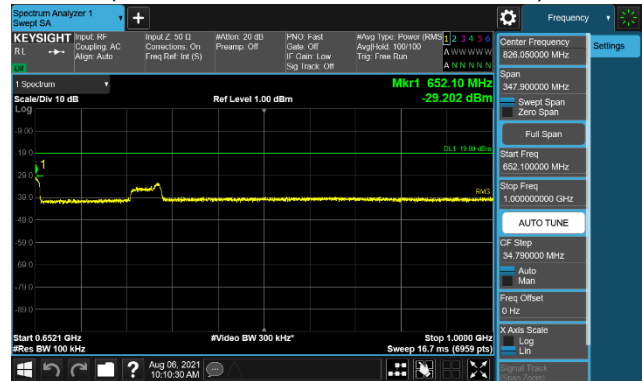
Plot 7-147. Conducted Spurious Emission Plot (9kHz to 150kHz)
(B71 LTE 2C 10M+10M Conti – Low Channel)



Plot 7-148. Conducted Spurious Emission Plot (150kHz to 30MHz)
(B71 LTE 2C 10M+10M Conti – Low Channel)



Plot 7-149. Conducted Spurious Emission Plot (30MHz to 616.9MHz)
(B71 LTE 2C 10M+10M Conti – Low Channel)

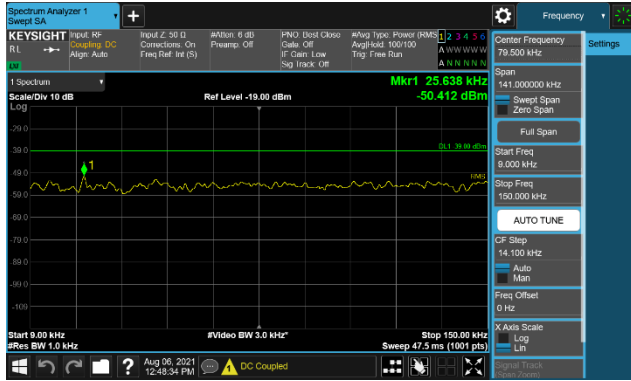


Plot 7-150. Conducted Spurious Emission Plot (652.1MHz to 1GHz)
(B71 LTE 2C 10M+10M Conti – Low Channel)



Plot 7-151. Conducted Spurious Emission Plot (1GHz to 8GHz)
(B71 LTE 2C 10M+10M Conti – Low Channel)

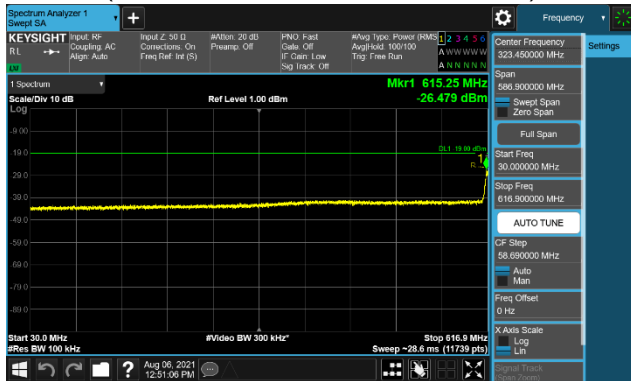
FCC ID: A3LRF4435D-71A	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 105 of 166



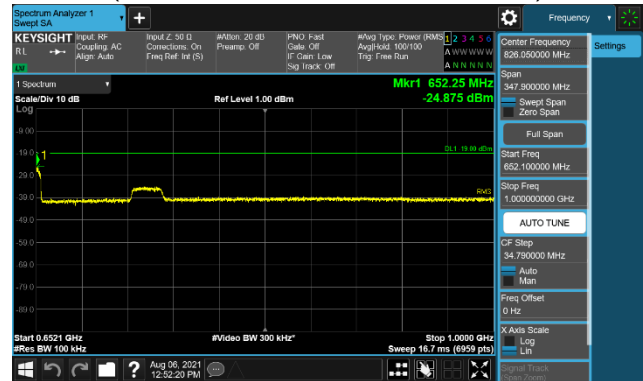
Plot 7-152. Conducted Spurious Emission Plot (9kHz to 150kHz)
(B71 LTE 2C 10M+10M Conti – Mid Channel)



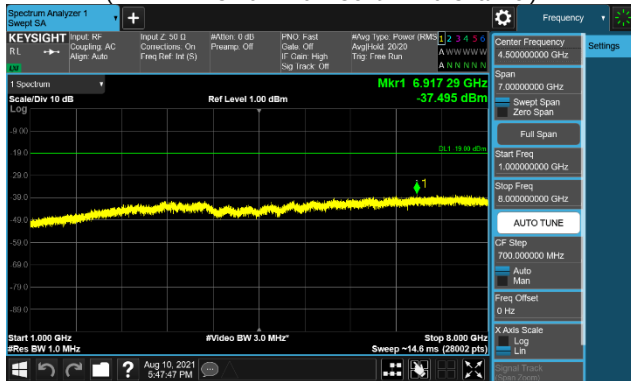
Plot 7-153. Conducted Spurious Emission Plot (150kHz to 30MHz)
(B71 LTE 2C 10M+10M Conti – Mid Channel)



Plot 7-154. Conducted Spurious Emission Plot (30MHz to 616.9MHz)
(B71 LTE 2C 10M+10M Conti – Mid Channel)

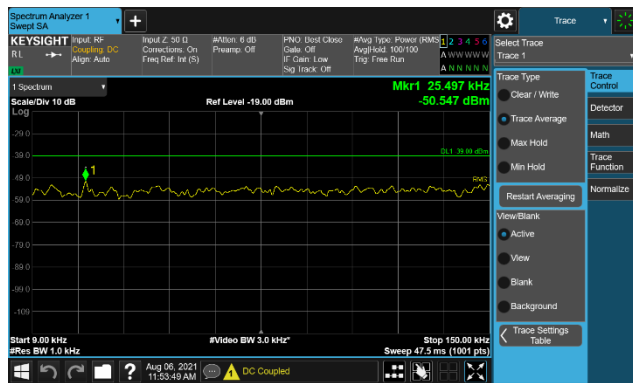


Plot 7-155. Conducted Spurious Emission Plot (652.1MHz to 1GHz)
(B71 LTE 2C 10M+10M Conti – Mid Channel)

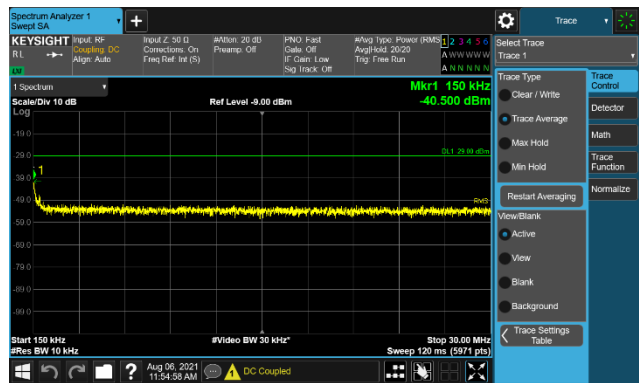


Plot 7-156. Conducted Spurious Emission Plot (1GHz to 8GHz)
(B71 LTE 2C 10M+10M Conti – Mid Channel)

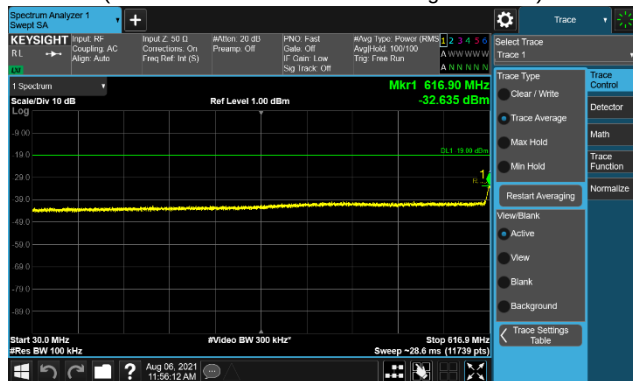
FCC ID: A3LRF4435D-71A	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 106 of 166



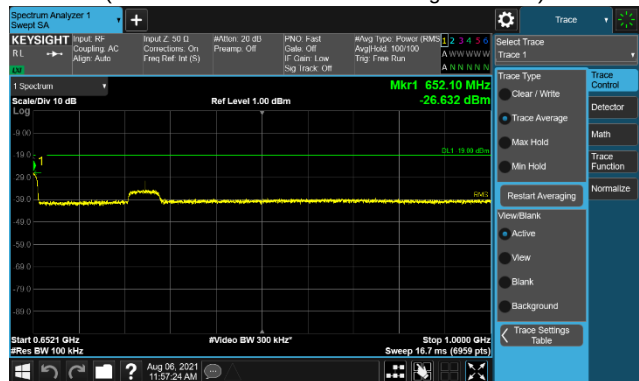
Plot 7-157. Conducted Spurious Emission Plot (9kHz to 150kHz)
(B71 LTE 2C 10M+10M Conti – High Channel)



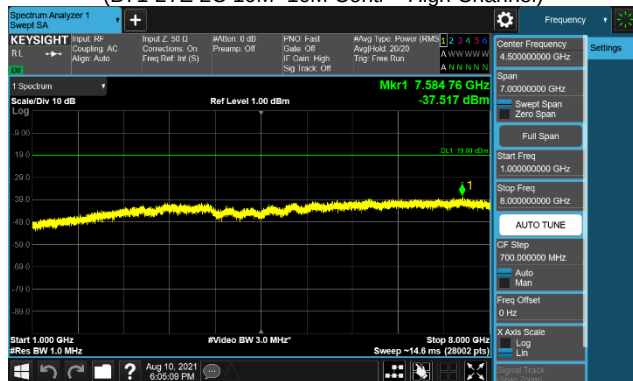
Plot 7-158. Conducted Spurious Emission Plot (150kHz to 30MHz)
(B71 LTE 2C 10M+10M Conti – High Channel)



Plot 7-159. Conducted Spurious Emission Plot (30MHz to 616.9MHz)
(B71 LTE 2C 10M+10M Conti – High Channel)



Plot 7-160. Conducted Spurious Emission Plot (652.1MHz to 1GHz)
(B71 LTE 2C 10M+10M Conti – High Channel)

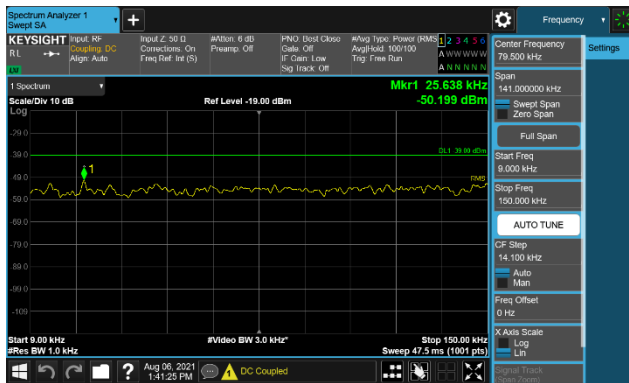


Plot 7-161. Conducted Spurious Emission Plot (1GHz to 8GHz)
(B71 LTE 2C 10M+10M Conti – High Channel)

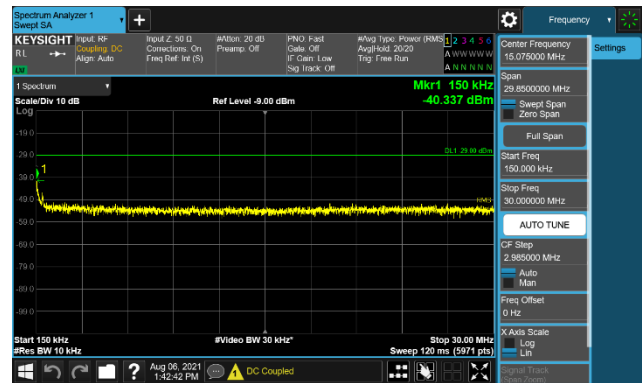
FCC ID: A3LRF4435D-71A	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 107 of 166

Port #	Measurement Range	Level(dBm)	Limit (dBm)
		QPSK	
1	9 kHz to 150 kHz	-50.20	-39.0
	150 kHz to 30 MHz	-40.34	-29.0
	30 MHz to 616.9 MHz	-23.88	-19.0
	652.1 MHz to 1 GHz	-24.62	-19.0
	1 GHz to 8 GHz	-39.61	-19.0

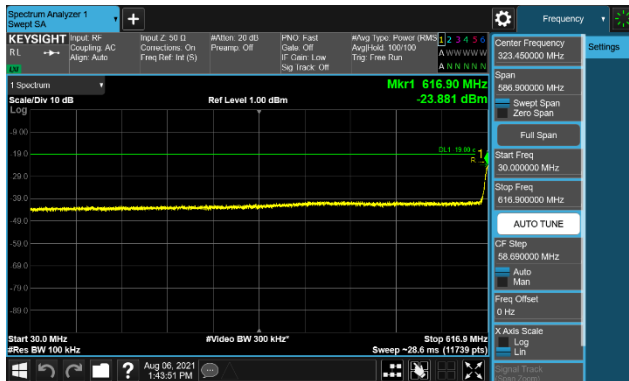
Table 7-45. Conducted Spurious Emission Summary Data (B71 LTE 2C 10M+10M Non-conti)



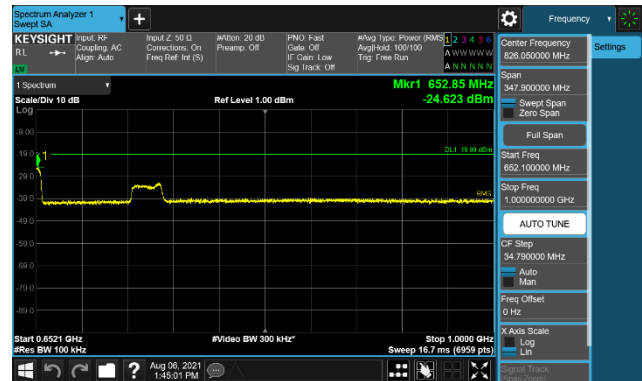
Plot 7-162. Conducted Spurious Emission Plot (9kHz to 150kHz)
(B71 LTE 2C 10M+10M Non-conti)



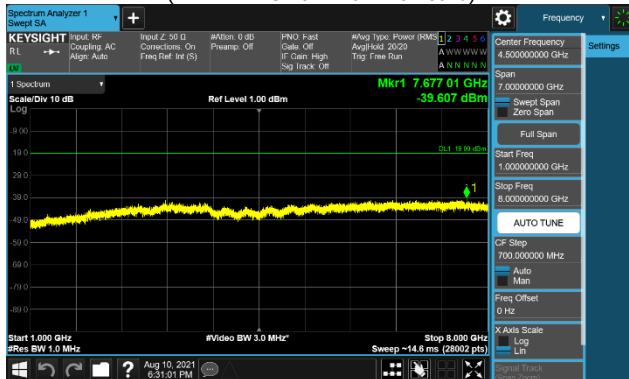
Plot 7-163. Conducted Spurious Emission Plot (150kHz to 30MHz)
(B71 LTE 2C 10M+10M Non-conti)



Plot 7-164. Conducted Spurious Emission Plot (30MHz to 616.9MHz)
(B71 LTE 2C 10M+10M Non-conti)



Plot 7-165. Conducted Spurious Emission Plot (652.1MHz to 1GHz)
(B71 LTE 2C 10M+10M Non-conti)

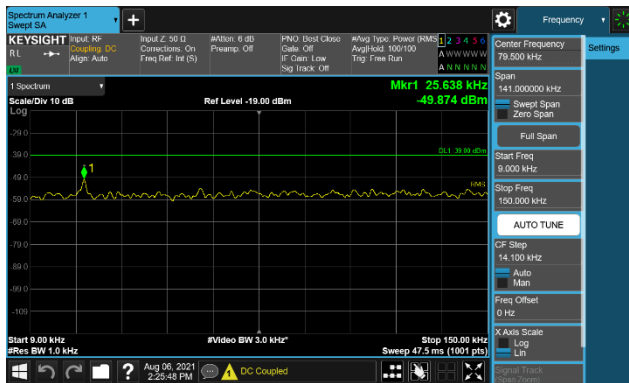


Plot 7-166. Conducted Spurious Emission Plot (1GHz to 8GHz)
(B71 LTE 2C 10M+10M Non-conti)

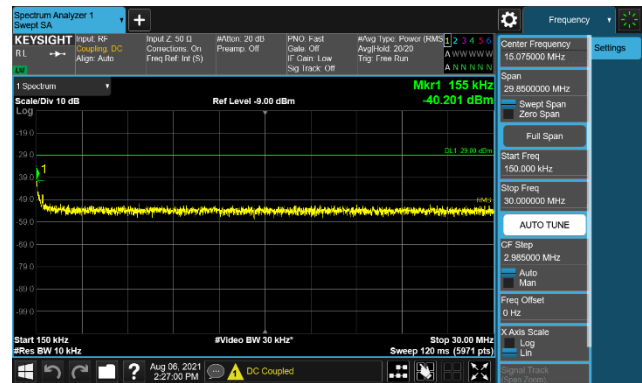
FCC ID: A3LRF4435D-71A	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 108 of 166

Port #	Measurement Range	Level (dBm)	Limit (dBm)
		QPSK	
2	9 kHz to 150 kHz	-49.87	-39.0
	150 kHz to 30 MHz	-40.20	-29.0
	30 MHz to 616.9 MHz	-24.96	-19.0
	652.1 MHz to 1 GHz	-25.39	-19.0
	1 GHz to 8 GHz	-38.16	-19.0

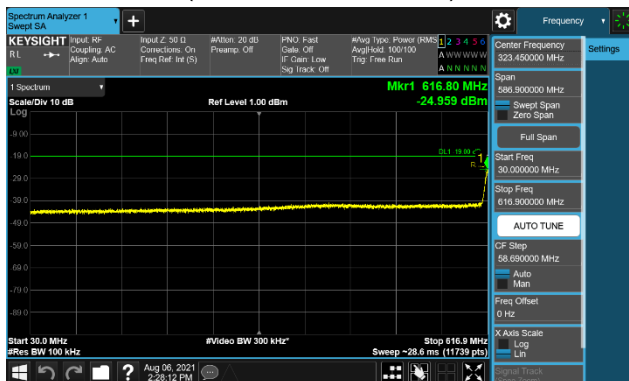
Table 7-46. Conducted Spurious Emission Summary Data (B71 LTE 2C 15M+20M Conti)



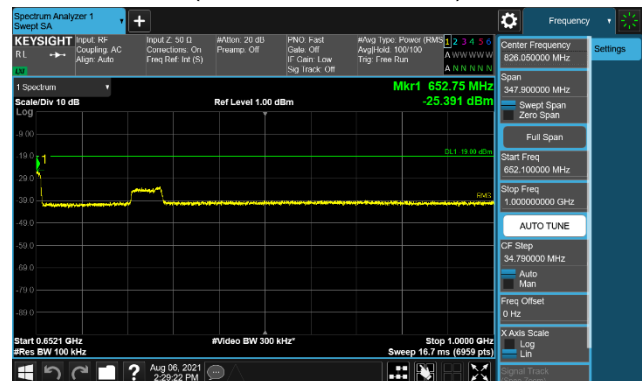
Plot 7-167. Conducted Spurious Emission Plot (9kHz to 150kHz)
(B71 LTE 2C 15M+20M Conti)



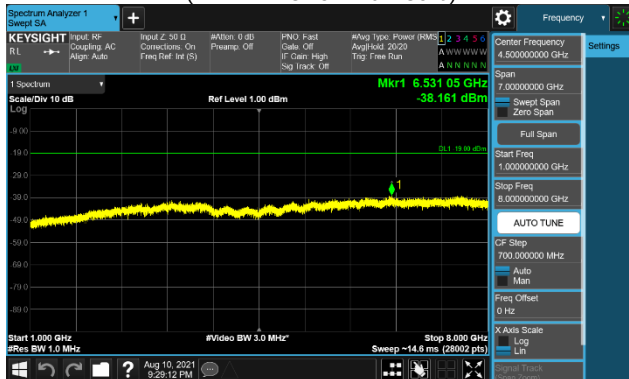
Plot 7-168. Conducted Spurious Emission Plot (150kHz to 30MHz)
(B71 LTE 2C 15M+20M Conti)



Plot 7-169. Conducted Spurious Emission Plot (30MHz to 616.9MHz)
(B71 LTE 2C 15M+20M Conti)



Plot 7-170. Conducted Spurious Emission Plot (652.1MHz to 1GHz)
(B71 LTE 2C 15M+20M Conti)



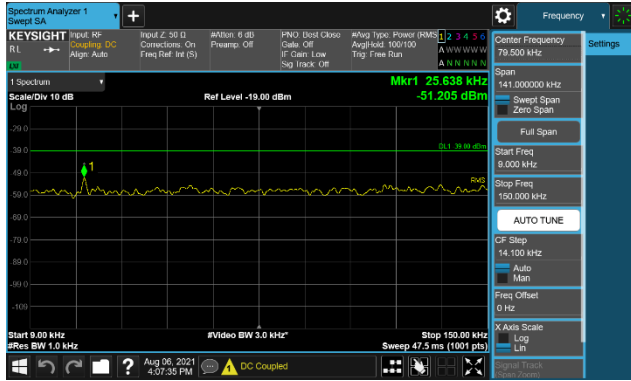
Plot 7-171. Conducted Spurious Emission Plot (1GHz to 8GHz)
(B71 LTE 2C 15M+20M Conti)

FCC ID: A3LRF4435D-71A	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 109 of 166

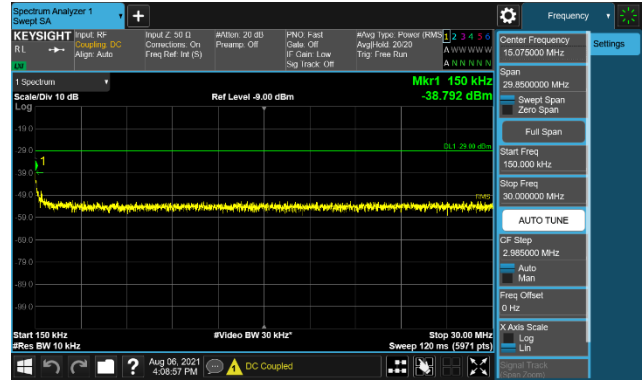
Ch.	Port #	Measurement Range	Level (dBm)	Limit (dBm)
			64QAM	
Low	0	9 kHz to 150 kHz	-51.21	-39.0
		150 kHz to 30 MHz	-38.79	-29.0
		30 MHz to 727.9 MHz	-28.28	-19.0
		746.1 MHz to 1 GHz	-33.74	-19.0
		1 GHz to 8 GHz	-37.57	-19.0
Middle	0	9 kHz to 150 kHz	-49.88	-39.0
		150 kHz to 30 MHz	-39.68	-29.0
		30 MHz to 727.9 MHz	-31.64	-19.0
		746.1 MHz to 1 GHz	-32.36	-19.0
		1 GHz to 8 GHz	-37.23	-19.0
High	1	9 kHz to 150 kHz	-49.27	-39.0
		150 kHz to 30 MHz	-38.19	-29.0
		30 MHz to 727.9 MHz	-31.69	-19.0
		746.1 MHz to 1 GHz	-22.61	-19.0
		1 GHz to 8 GHz	-39.41	-19.0

Table 7-47. Conducted Spurious Emission Summary Data (B85 LTE 1C 5M)

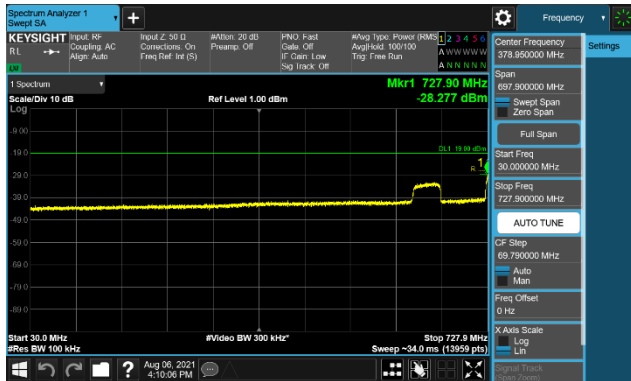
FCC ID: A3LRF4435D-71A		MEASUREMENT REPORT (CERTIFICATION)		Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 110 of 166



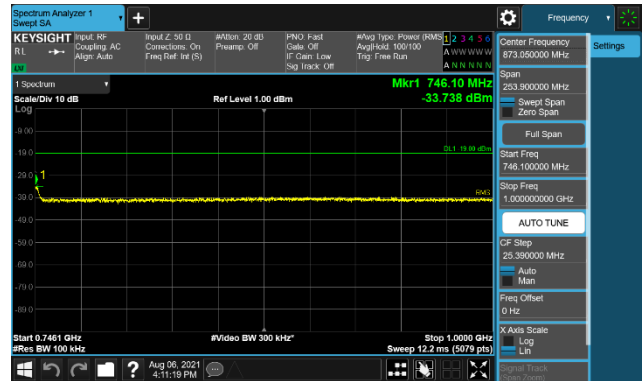
Plot 7-172. Conducted Spurious Emission Plot (9kHz to 150kHz)
(B85 LTE 1C 5M – Low Channel)



Plot 7-173. Conducted Spurious Emission Plot (150kHz to 30MHz)
(B85 LTE 1C 5M – Low Channel)



Plot 7-174. Conducted Spurious Emission Plot (30MHz to 727.9MHz)
(B85 LTE 1C 5M – Low Channel)

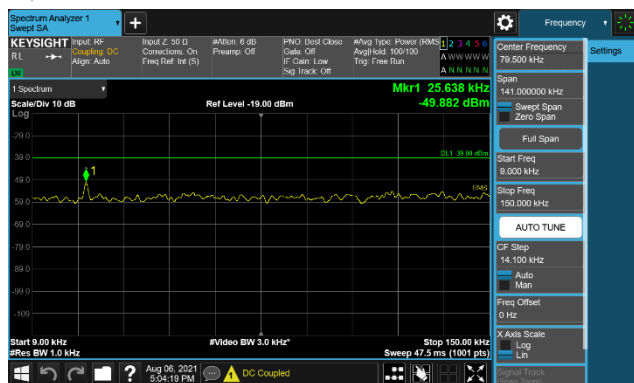


Plot 7-175. Conducted Spurious Emission Plot (746.1MHz to 1GHz)
(B85 LTE 1C 5M – Low Channel)

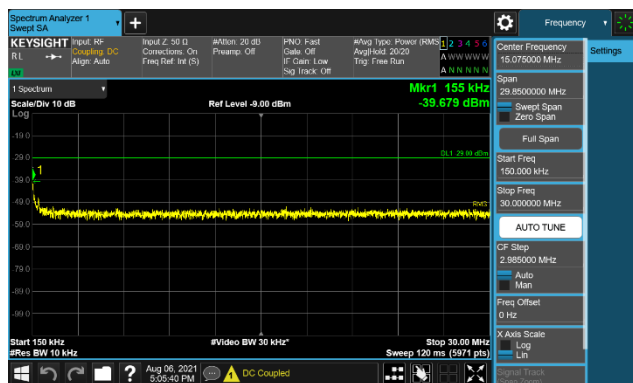


Plot 7-176. Conducted Spurious Emission Plot (1GHz to 8GHz)
(B85 LTE 1C 5M – Low Channel)

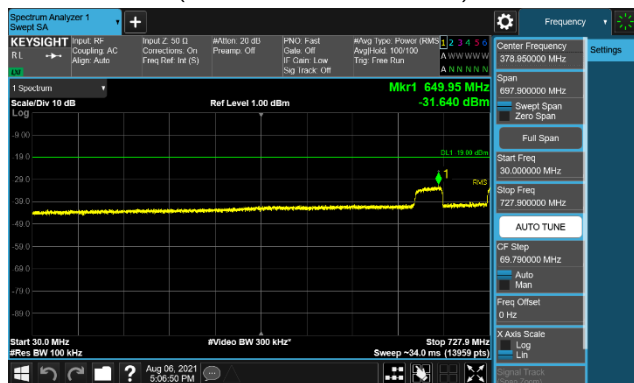
FCC ID: A3LRF4435D-71A	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 111 of 166



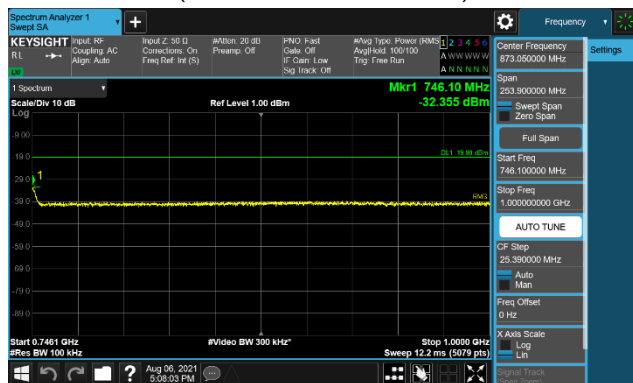
Plot 7-177. Conducted Spurious Emission Plot (9kHz to 150kHz)
(B85 LTE 1C 5M – Mid Channel)



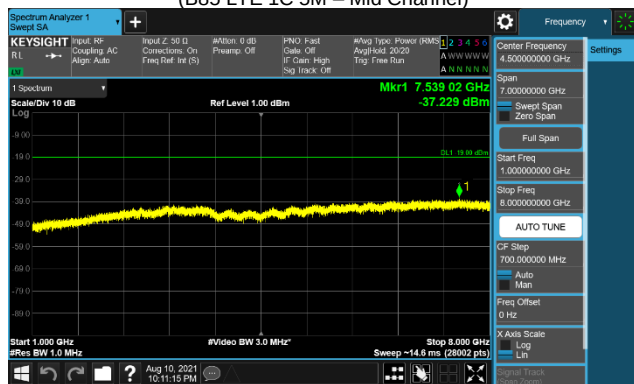
Plot 7-178. Conducted Spurious Emission Plot (150kHz to 30MHz)
(B85 LTE 1C 5M – Mid Channel)



Plot 7-179. Conducted Spurious Emission Plot (30MHz to 727.9MHz)
(B85 LTE 1C 5M – Mid Channel)

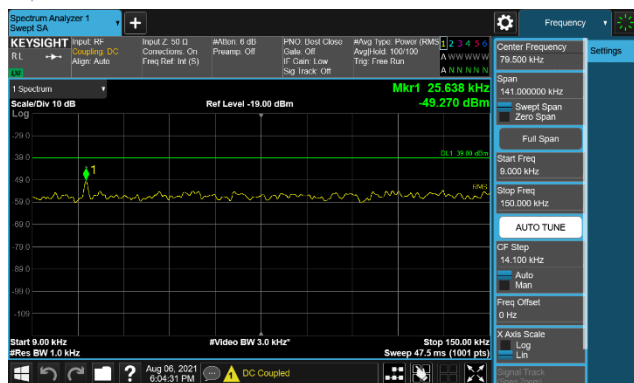


Plot 7-180. Conducted Spurious Emission Plot (746.1MHz to 1GHz)
(B85 LTE 1C 5M – Mid Channel)

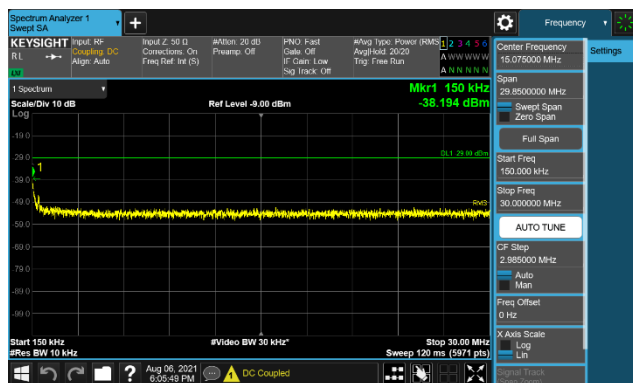


Plot 7-181. Conducted Spurious Emission Plot (1GHz to 8GHz)
(B85 LTE 1C 5M – Mid Channel)

FCC ID: A3LRF4435D-71A	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 112 of 166



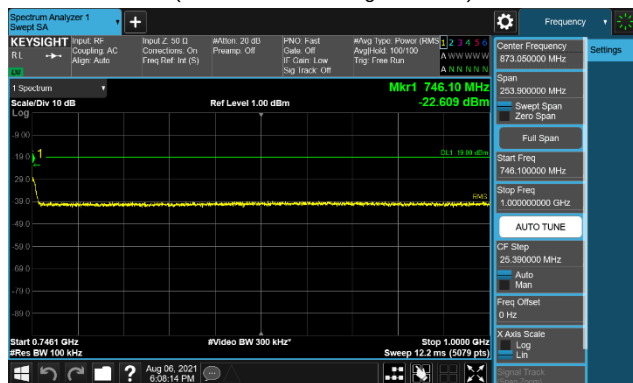
Plot 7-182. Conducted Spurious Emission Plot (9kHz to 150kHz)
(B85 LTE 1C 5M – High Channel)



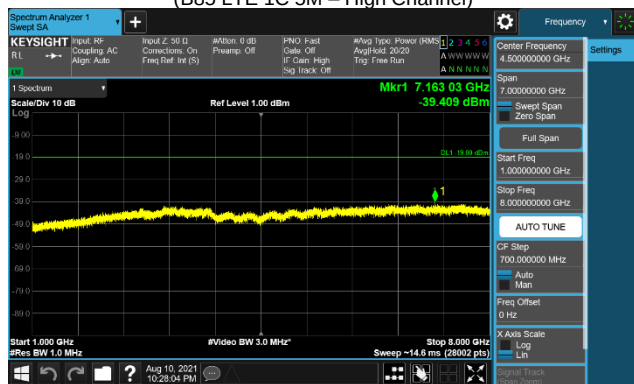
Plot 7-183. Conducted Spurious Emission Plot (150kHz to 30MHz)
(B85 LTE 1C 5M – High Channel)



Plot 7-184. Conducted Spurious Emission Plot (30MHz to 727.9MHz)
(B85 LTE 1C 5M – High Channel)



Plot 7-185. Conducted Spurious Emission Plot (746.1MHz to 1GHz)
(B85 LTE 1C 5M – High Channel)



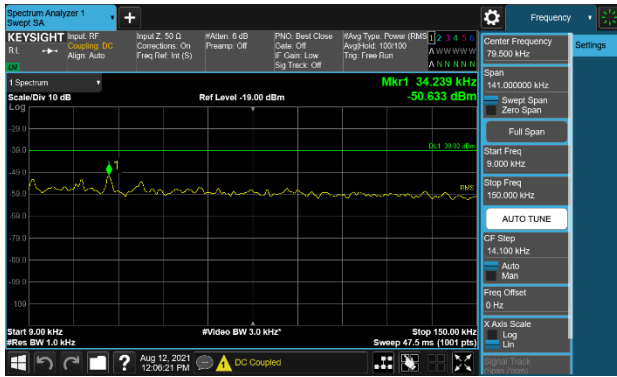
Plot 7-186. Conducted Spurious Emission Plot (1GHz to 8GHz)
(B85 LTE 1C 5M – High Channel)

FCC ID: A3LRF4435D-71A	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 113 of 166

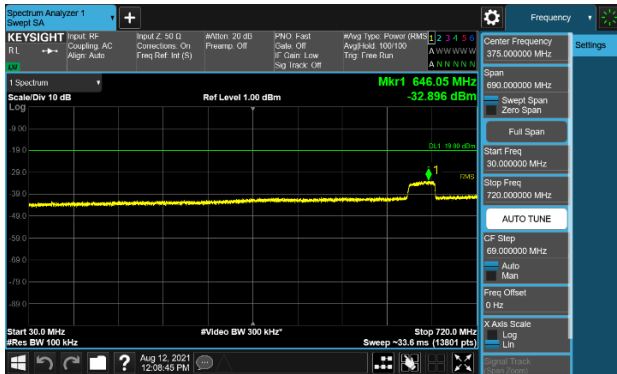
Ch	Port #	Measurement Range	Level (dBm)	Limit (dBm)
			QPSK	
Low	3	9 kHz to 150 kHz	-50.63	-39.0
		150 kHz to 30 MHz	-39.67	-29.0
		30 MHz to 720 MHz	-32.90	-19.0
		720 MHz to 727.9 MHz	-22.11	-19.0
		746.1 MHz to 750 MHz	-36.70	-19.0
		750 MHz to 1 GHz	-38.43	-19.0
		1 GHz to 8 GHz	-38.24	-19.0
Middle	3	9 kHz to 150 kHz	-52.54	-39.0
		150 kHz to 30 MHz	-39.36	-29.0
		30 MHz to 720 MHz	-33.26	-19.0
		720 MHz to 727.9 MHz	-35.59	-19.0
		746.1 MHz to 750 MHz	-35.59	-19.0
		750 MHz to 1 GHz	-38.36	-19.0
		1 GHz to 8 GHz	-38.01	-19.0
High	3	9 kHz to 150 kHz	-48.15	-39.0
		150 kHz to 30 MHz	-38.42	-29.0
		30 MHz to 720 MHz	-32.19	-19.0
		720 MHz to 727.9 MHz	-34.61	-19.0
		746.1 MHz to 750 MHz	-23.82	-19.0
		750 MHz to 1 GHz	-38.40	-19.0
		1 GHz to 8 GHz	-38.18	-19.0

**Table 7-48. Conducted Spurious Emission Summary Data
(B85 NB-IoT(SA) 1C)**

FCC ID: A3LRF4435D-71A		MEASUREMENT REPORT (CERTIFICATION)		Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)	Page 114 of 166	



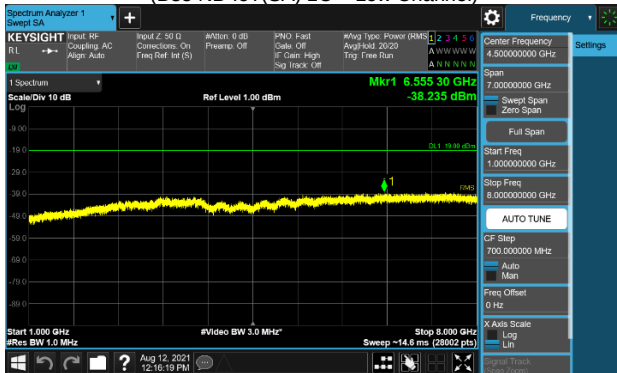
Plot 7-187. Conducted Spurious Emission Plot (9kHz to 150kHz)
(B85 NB-IoT(SA) 1C – Low Channel)



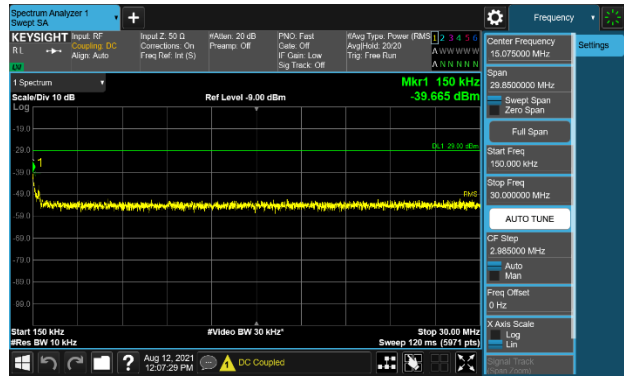
Plot 7-189. Conducted Spurious Emission Plot (30MHz to 720MHz)
(B85 NB-IoT(SA) 1C – Low Channel)



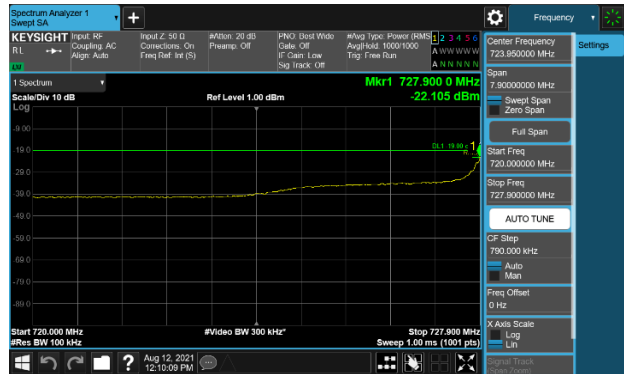
Plot 7-191. Conducted Spurious Emission Plot (746.1MHz to 750MHz)
(B85 NB-IoT(SA) 1C – Low Channel)



Plot 7-193. Conducted Spurious Emission Plot (1GHz to 8GHz)
(B85 NB-IoT(SA) 1C – Low Channel)



Plot 7-188. Conducted Spurious Emission Plot (150kHz to 30MHz)
(B85 NB-IoT(SA) 1C – Low Channel)

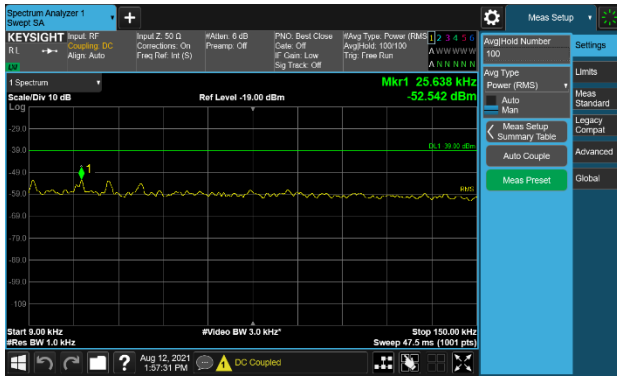


Plot 7-190. Conducted Spurious Emission Plot (720MHz to 727.9MHz)
(B85 NB-IoT(SA) 1C – Low Channel)

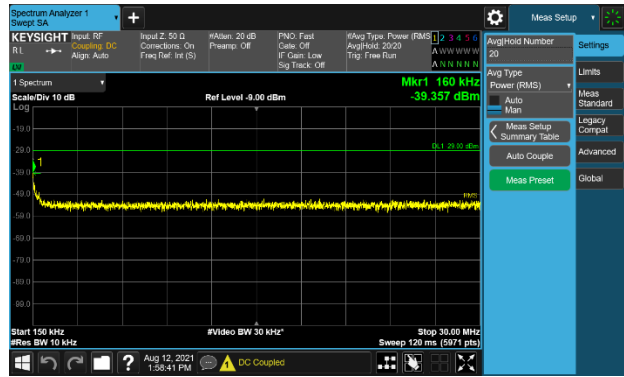


Plot 7-192. Conducted Spurious Emission Plot (750MHz to 1GHz)
(B85 NB-IoT(SA) 1C – Low Channel)

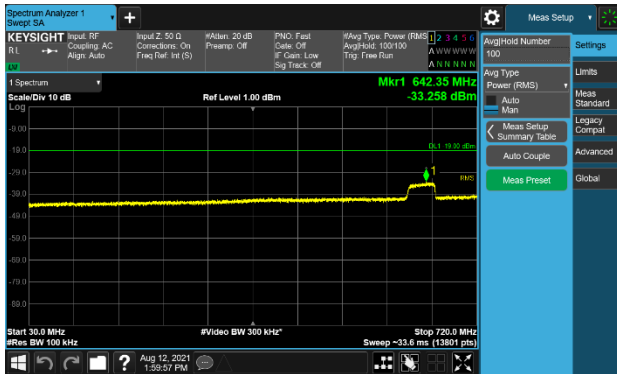
FCC ID: A3LRF4435D-71A	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 115 of 166



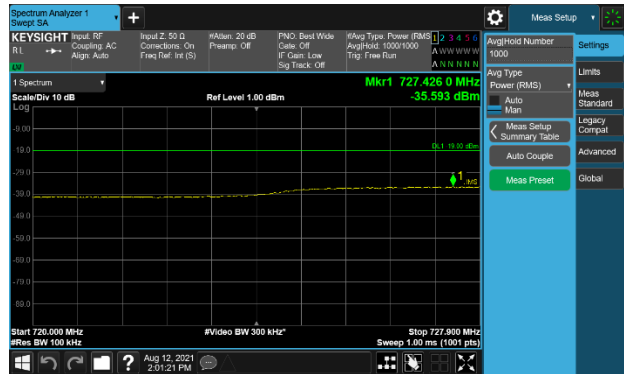
Plot 7-194. Conducted Spurious Emission Plot (9kHz to 150kHz)
(B85 NB-IoT(SA) 1C – Mid Channel)



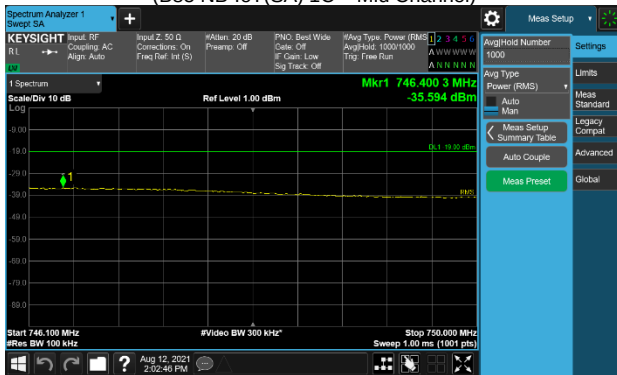
Plot 7-195. Conducted Spurious Emission Plot (150kHz to 30MHz)
(B85 NB-IoT(SA) 1C – Mid Channel)



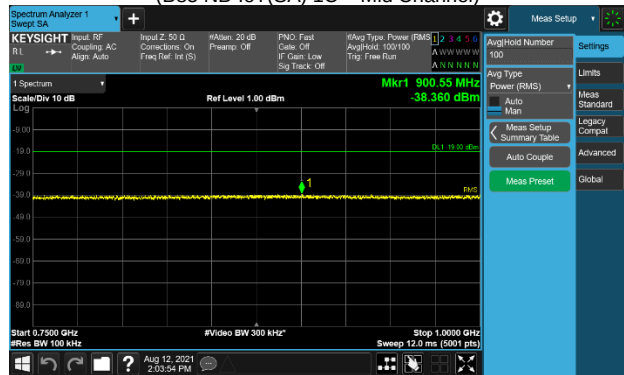
Plot 7-196. Conducted Spurious Emission Plot (30MHz to 720MHz)
(B85 NB-IoT(SA) 1C – Mid Channel)



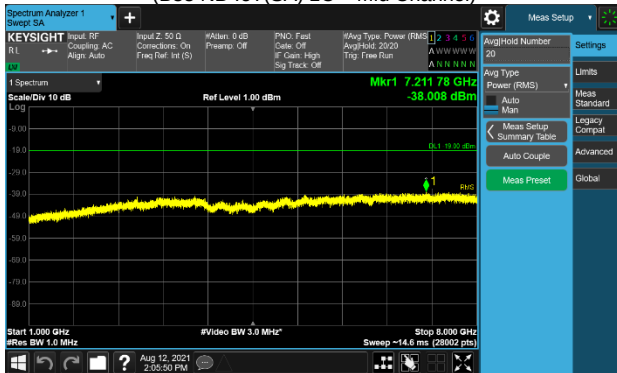
Plot 7-197. Conducted Spurious Emission Plot (720MHz to 727.9MHz)
(B85 NB-IoT(SA) 1C – Mid Channel)



Plot 7-198. Conducted Spurious Emission Plot (746.1MHz to 750MHz)
(B85 NB-IoT(SA) 1C – Mid Channel)

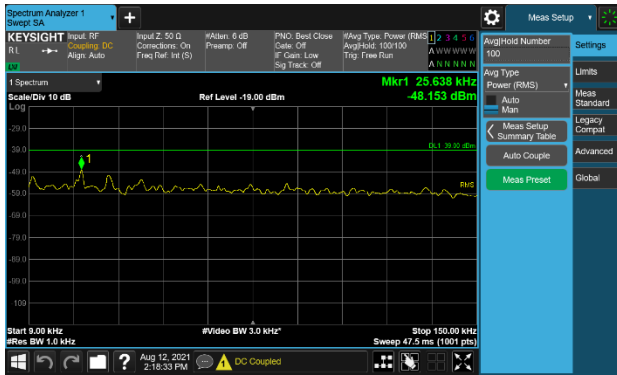


Plot 7-199. Conducted Spurious Emission Plot (750MHz to 1GHz)
(B85 NB-IoT(SA) 1C – Mid Channel)

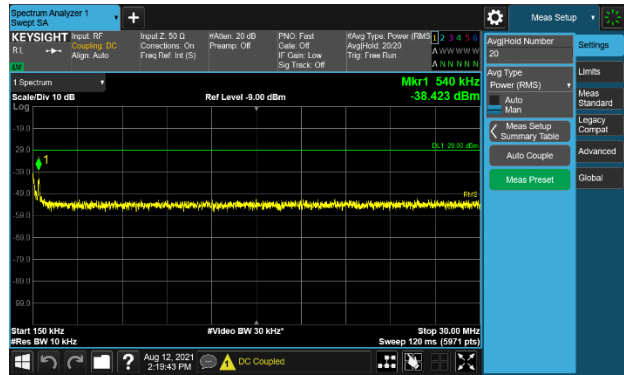


Plot 7-200. Conducted Spurious Emission Plot (1GHz to 8GHz)
(B85 NB-IoT(SA) 1C – Mid Channel)

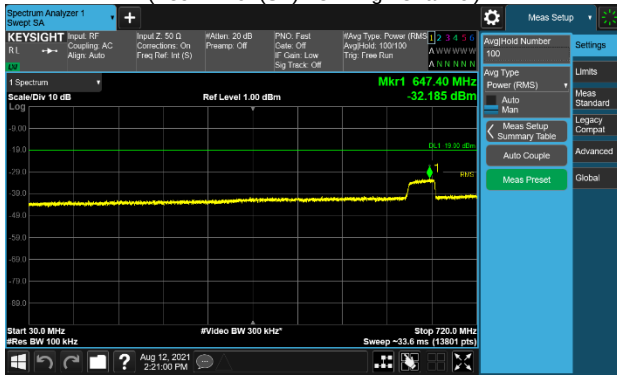
FCC ID: A3LRF4435D-71A	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 116 of 166



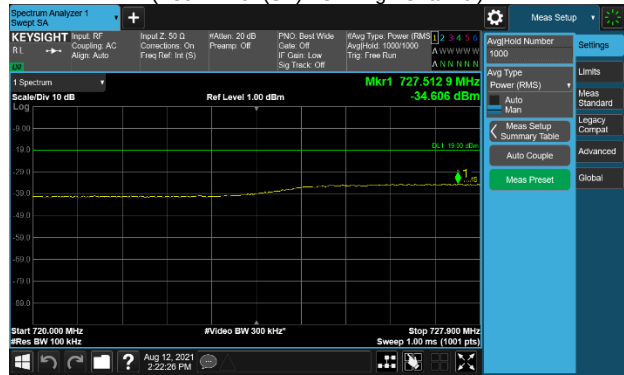
Plot 7-201. Conducted Spurious Emission Plot (9kHz to 150kHz)
(B85 NB-IoT(SA) 1C – High Channel)



Plot 7-202. Conducted Spurious Emission Plot (150kHz to 30MHz)
(B85 NB-IoT(SA) 1C – High Channel)



Plot 7-203. Conducted Spurious Emission Plot (30MHz to 720MHz)
(B85 NB-IoT(SA) 1C – High Channel)

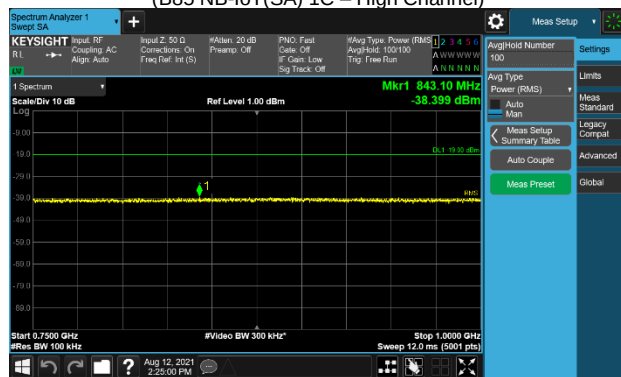


Plot 7-204. Conducted Spurious Emission Plot (720MHz to 727.9MHz)
(B85 NB-IoT(SA) 1C – High Channel)

FCC ID: A3LRF4435D-71A	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 117 of 166



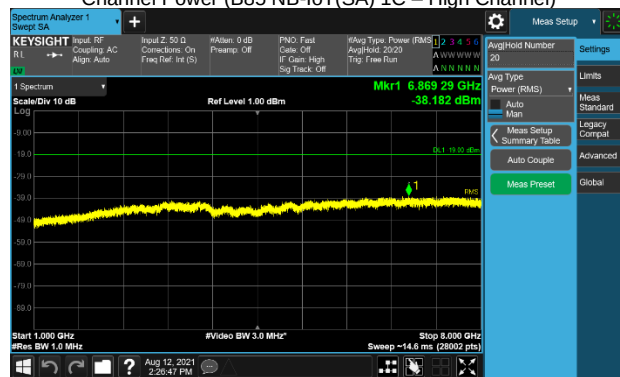
Plot 7-205. Conducted Spurious Emission Plot (746.1MHz to 750MHz)
(B85 NB-IoT(SA) 1C – High Channel)



Plot 7-207. Conducted Spurious Emission Plot (750MHz to 1GHz)
(B85 NB-IoT(SA) 1C – High Channel)



Plot 7-206. Conducted Spurious Emission Plot (746.1MHz to 750MHz)
Channel Power (B85 NB-IoT(SA) 1C – High Channel)



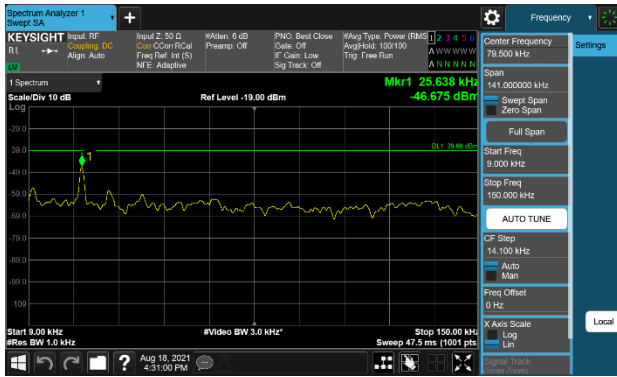
Plot 7-208. Conducted Spurious Emission Plot (1GHz to 8GHz)
(B85 NB-IoT(SA) 1C – High Channel)

FCC ID: A3LRF4435D-71A	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 118 of 166

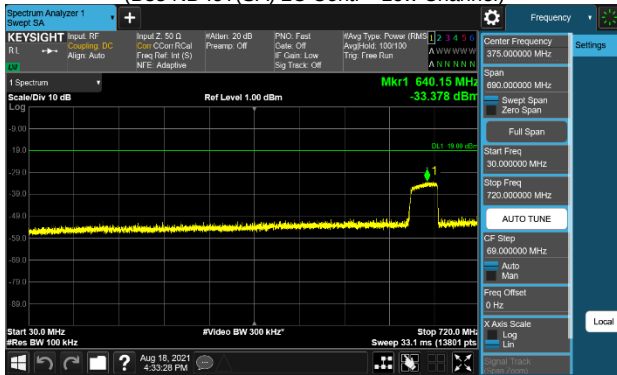
Ch.	Port #	Measurement Range	Level (dBm)	Limit (dBm)
			QPSK	
Low	2	9 kHz to 150 kHz	-46.68	-39.0
		150 kHz to 30 MHz	-45.85	-29.0
		30 MHz to 720 MHz	-33.38	-19.0
		720 MHz to 727.9 MHz	-22.16	-19.0
		746.1 MHz to 750 MHz	-36.76	-19.0
		750 MHz to 1 GHz	-48.00	-19.0
		1 GHz to 8 GHz	-37.86	-19.0
Middle	1	9 kHz to 150 kHz	-59.24	-39.0
		150 kHz to 30 MHz	-44.26	-29.0
		30 MHz to 720 MHz	-33.54	-19.0
		720 MHz to 727.9 MHz	-36.75	-19.0
		746.1 MHz to 750 MHz	-36.15	-19.0
		750 MHz to 1 GHz	-47.94	-19.0
		1 GHz to 8 GHz	-38.61	-19.0
High	3	9 kHz to 150 kHz	-57.36	-39.0
		150 kHz to 30 MHz	-44.58	-29.0
		30 MHz to 720 MHz	-32.41	-19.0
		720 MHz to 727.9 MHz	-35.28	-19.0
		746.1 MHz to 750 MHz	-20.64	-19.0
		750 MHz to 1 GHz	-47.97	-19.0
		1 GHz to 8 GHz	-37.43	-19.0

**Table 7-49. Conducted Spurious Emission Summary Data
(B85 NB-IoT(SA) 2C Conti)**

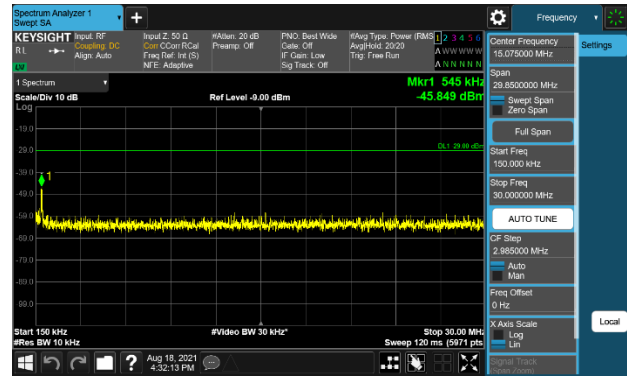
FCC ID: A3LRF4435D-71A		MEASUREMENT REPORT (CERTIFICATION)		Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)	Page 119 of 166	



Plot 7-200. Conducted Spurious Emission Plot (9kHz to 150kHz)
(B85 NB-IoT(SA) 2C Conti – Low Channel)



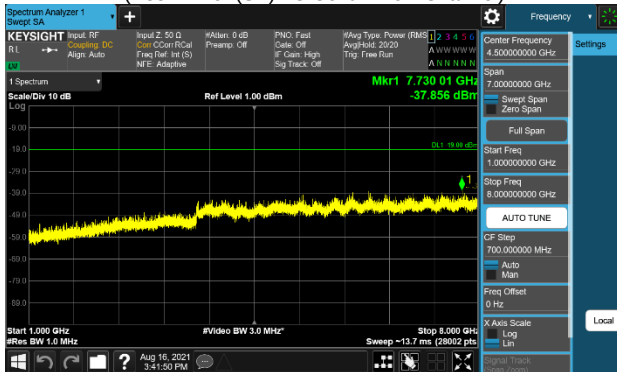
Plot 7-211. Conducted Spurious Emission Plot (30MHz to 720MHz)
(B85 NB-IoT(SA) 2C Conti – Low Channel)



Plot 7-213. Conducted Spurious Emission Plot (746.1MHz to 750MHz)
(B85 NB-IoT(SA) 2C Conti – Low Channel)



Plot 7-212. Conducted Spurious Emission Plot (720MHz to 727.9MHz)
(B85 NB-IoT(SA) 2C Conti – Low Channel)



Plot 7-214. Conducted Spurious Emission Plot (750MHz to 1GHz)
(B85 NB-IoT(SA) 2C Conti – Low Channel)

FCC ID: A3LRF4435D-71A	PCTEST ENGINEERING LABORATORY, INC.	MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Technical Manager
Test Report S/N: 8K21061101.A3L	Test Dates: 08/04/2021 - 08/24/2021	EUT Type: RRU (RF4435d)		Page 120 of 166